

# Specifications

Drawing No.	USY1M-H1-17146-00	1 / 10
Issued Date.	Feb,20,2017	

## Messrs: Digi-Key

**Note: Part Number will be revised in case of specification change.**

Product Type	Quartz Crystal
Series	CX2520DB
Frequency	19200kHz
Customer Part Number	-
Customer Specification Number	-
KYOCERA Part Number	CX2520DB19200H0KFQC2
Remarks	Pb-Free, RoHS Compliant, MSL 1

### Customer Approval

Approval Signature	Approved Date	
	Department	
	Person in charge	

### Seller

**KYOCERA Crystal Device Corporation**  
(Sales Division)  
6 Takeda Tobadono-cho, Fushimi-ku, Kyoto  
612-8501 Japan  
TEL. No. 075-604-3500  
FAX. No. 075-604-3501

### Manufacturer

**KYOCERA Crystal Device Corporation**  
Crystal Units Division  
5850, Higashine-Koh, Higashine-Shi, Yamagata  
999-3701 Japan  
TEL. No. 0237-43-5611  
FAX. No. 0237-43-5615

Design Department	Quality Assurance	Approved by	Checked by	Issued by
KYOCERA Crystal Device Corporation Crystal Unit Design Engineering Section Crystal Units Division	S.Itoh	T.Soda	A.Muraoka	Y.Nozaki

## Revision History

Rev.No.	Description of revise	Date	Approved by	Checked by	Issued by
00	First Edition	Feb,20,2017	T.Soda	A.Muraoka	Y.Nozaki

### 1. APPLICATION

The purpose of this document is applied to CX2520DB quartz crystal.

### 2. KYOCERA PART NUMBER

CX2520DB19200H0KFQC2

### 3. RATINGS

Items	SYMB.	Rating	Unit	Remarks
Operating Temperature range	Topr	-20 to +70	deg. C	
Storage Temperature range	Tstg	-40 to +85	deg. C	

### 4. CHARACTERISTICS

#### 4-1 ELECTRICAL CHARACTERISTICS

Items	Electrical Specification				Test Condition	Remarks
	SYMB.	Min	Typ.	Max		
Mode of Vibration		Fundamental				
Nominal Frequency	F0		19.2		MHz	
Nominal Temperature	T <sub>NOM</sub>		+25		deg. C	
Load Capacitance	CL		12.0		pF	
Frequency tolerance	df/F	-30.0		+30.0	PPM	+25±3°C
Frequency Temperature Characteristics	df/t	-30.0		+30.0		-20 to +70
Frequency Aging Rate		-1.0		+1.0	PPM	+25±3°C 1 <sup>st</sup> year
Equivalent Series Resistance	ESR			80	Ohms	CL=SERIES
Drive Level	Pd	0.01		100	μW	+25±3°C
Insulation Resistance	IR	500			M ohms	100V(DC) +25±3°C

Unless otherwise specified, these indicators have been met under the operating temperature range.

### 5. Measurement Condition

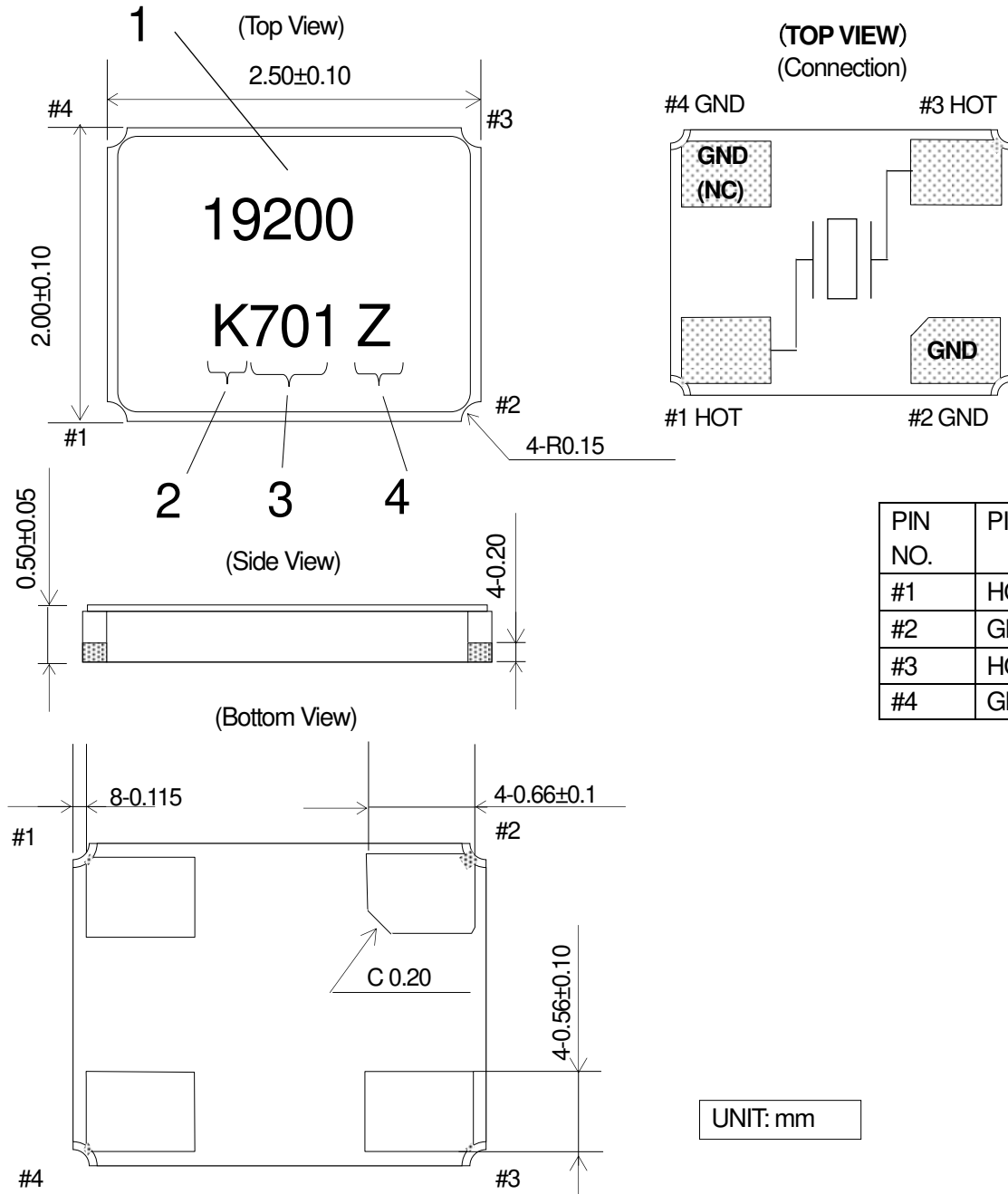
Frequency measurement

Measuring instrument : IEC PI-Network Test Fixture  
IEC 60444-8 STD (Pi circuit 41901A)

Equivalent series resistance (ESR) measurement

Measuring instrument : IEC PI-Network Test Fixture  
Load Capacitance : Series

**6. APPEARANCES, PHYSICAL DIMENSION**  
**OUTLINE DIMENSION (not to scale)**



PIN NO.	PIN Layout
#1	HOT
#2	GND
#3	HOT
#4	GND

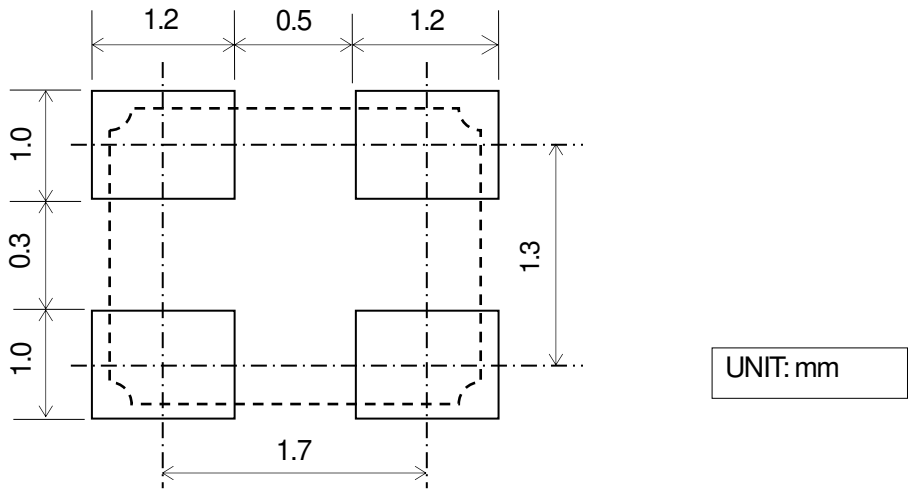
UNIT: mm

**MARKING**

- |   |                        |   |
|---|------------------------|---|
| 1 | Nominal Frequency      | First 5digit of the frequency is indicated.                     |
| 2 | Identification         | [K] is to indicate 1Pin direction.                              |
| 3 | Date Code              | Last 1 Digit of YEAR and WEEK (Ex) 2017,Jan,05 → 701            |
| 4 | Manufacturing Location | Y→Japan (Yamagata )<br>Z→Japan (Shiga Yohkaichi )<br>T→Thailand |

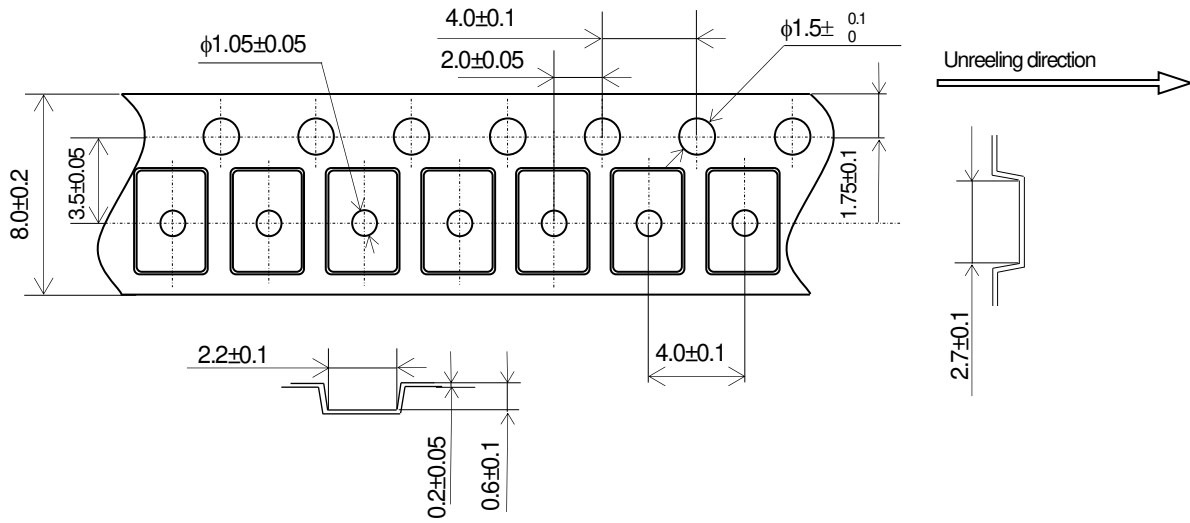
\*The font of marking is for reference only.

**7. RECOMMENDED LAND PATTERN (not to scale)**

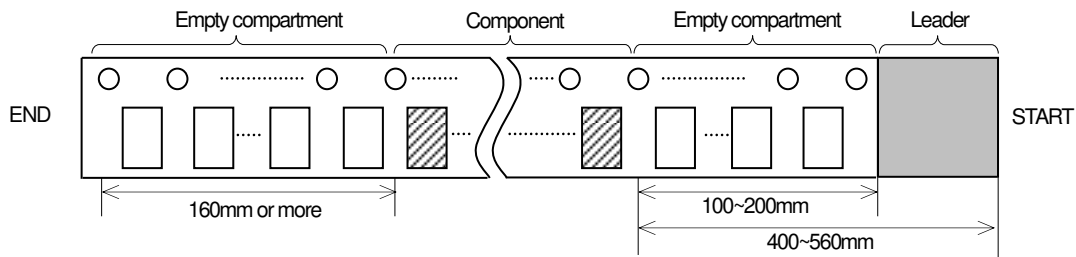


## 8. TAPING & REEL

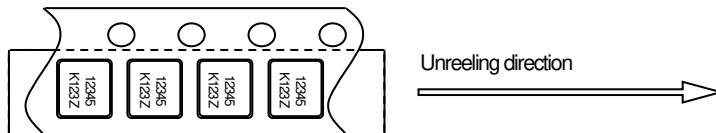
### 8-1. Dimensions



### 8-2. Leader and trailer tape

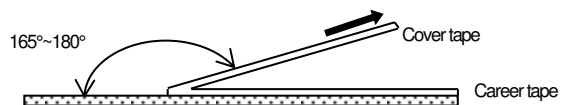


### 8-3. Direction (The direction shall be seen from the top cover tape side)

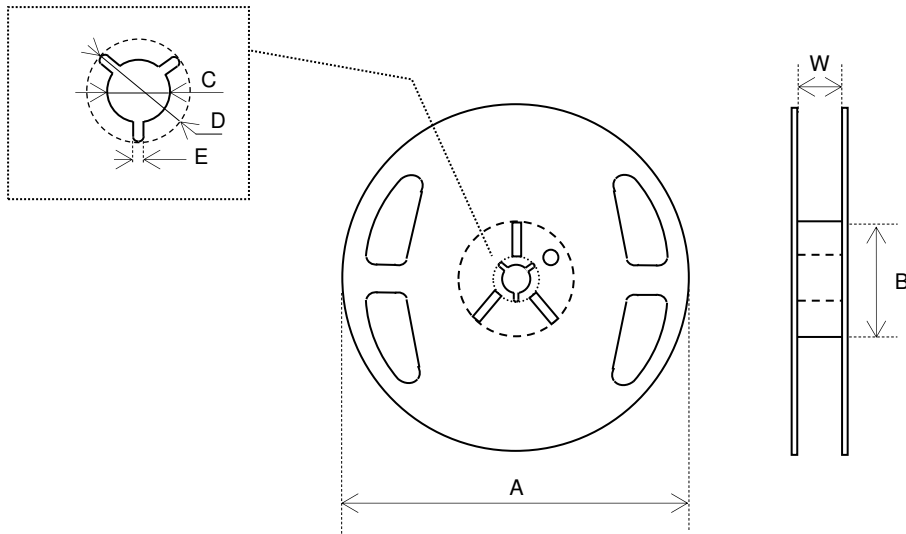


### 8-4. Specification

1. Material of the carrier tape is either polystyrene or A-PET (ESD).
2. Material of the cover tape is polyester (ESD).
3. The seal tape shall not cover the sprocket holes and not protrude from the carrier tape.
4. Tensile strength of carrier tape: 10N or more.
5. The R of the corner of each cavity is  $0.2R_{MAX}$ .
6. The alignment between centers of the cavity and sprocket hole shall be  $0.05$  mm or less.
7. The orientation shall be checked from the top cover tape side as shown in 8-3.
8. Peeling force of cover tape:  $0.1$  to  $1.0$  N.
9. The component will fall out naturally when cover tape is removed and set upside down.



8-5.Reel Specification



φ180 Reel (3,000 pcs Max.)

Symbol	A	B	C
Dimension	φ180 +0/-3	φ60 +1/-0	φ13±0.2
Symbol	D	E	W
Dimension	φ21±0.8	2.0±0.5	9±1

(Unit : mm)

φ330 Reel (12,000 pcs Max.)

Symbol	A	B	C
Dimension	φ330±2.0	φ100±1.0	φ13±0.2
Symbol	D	E	W
Dimension	φ21±0.8	2.0±0.5	9.4±1.0

(Unit : mm)

## 9. Environmental requirements

After conducting the following tests, component needs to meet below conditions.

Frequency: Fluctuation within  $\pm 10 \times 10^{-6}$

CI: Fluctuation within  $\pm 20\%$  or  $5\Omega$  whichever is larger

- 9.1 Resistance to Shock      Test condition  
3 times natural drop from 100cm onto hard wooden board.
- 9.2 Resistance to Vibration      Test condition  
frequency                      : 10 - 55 - 10 Hz  
Amplitude                      : 1.5mm  
Cycle time                      : 15 minutes  
Direction                      : X,Y,Z (3direction),2h each.
- 9.3 Resistance to Heat      Test condition  
The quartz crystal unit shall be stored at a temperature of  $+85\pm 2^\circ\text{C}$  for 500h and subjected to room temperature for 1h before measurement.
- 9.4 Resistance to Cold      Test condition  
The quartz crystal unit shall be stored at a temperature of  $-40\pm 2^\circ\text{C}$  for 500h and subjected to room temperature for 1h before measurement.
- 9.5 Thermal Shock      Test condition  
The quartz crystal unit shall be subjected to 500 temperature cycles shown in table below, Then it shall be subjected to room temperature for 1h before measurement.  
Cycle                      :  $-40\pm 2^\circ\text{C}$ (30min.)  $\rightarrow$   $+25\pm 2^\circ\text{C}$ (5min.)  
 $\rightarrow$   $+85\pm 2^\circ\text{C}$ (30min.)  $\rightarrow$   $+25\pm 2^\circ\text{C}$ (5min.)



9.6 Resistance to Moisture

Test condition

The quartz crystal unit shall be stored at a temperature of  $+60\pm 2^{\circ}\text{C}$  with relative humidity of 90% to 95% for 240 h. Then it shall be subjected to room temperature for 1h before measurement.

9.7 Soldering condition

1.) Type of solder

Material → lead free solder paste

Melting point →  $+220 \pm 5^{\circ}\text{C}$

2.) Reflow temp.profile

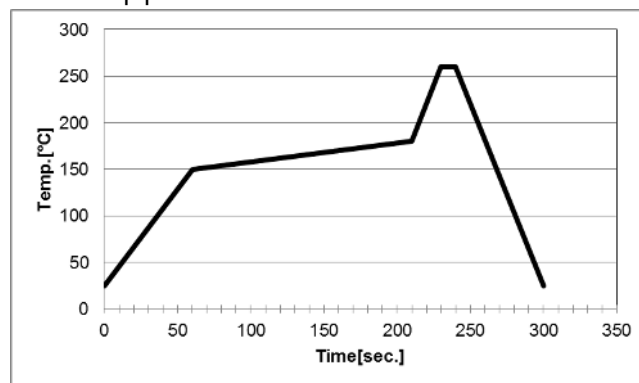
	Temp [°C]	Time[sec]
Preheating	+150 to +180	150 (typ.)
Peak	$+260 \pm 5$	30 (max.)
Total	---	300 (max.)

Frequency shift :  $\pm 2\text{ppm}$

3.) Hand Soldering  $+350^{\circ}\text{C}$  3 sec max

4.) Reflow Times 3 times in below Reflow temp. profile

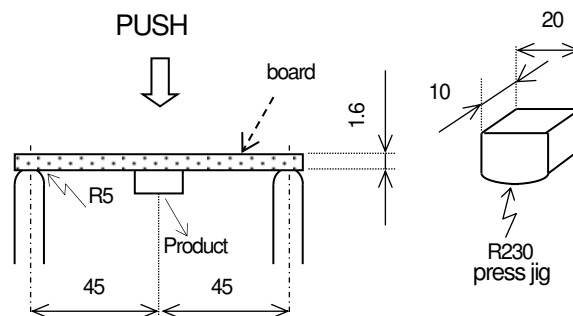
Reflow temp.profile



9.8 Bending Strength

Solder this product in center of the circuit board (40mm X 100mm), and add deflection of 3mm.

Test board :  $t=1.6\text{mm}$



UNIT : mm

## 10. Cautions for use

### (1) Soldering upon mounting

There is a possibility to influence product characteristics when Solder paste or conductive glue comes in contact with product lid or surface.

### (2) When using mounting machine

Please minimize the shock when using mounting machine to avoid any excess stress to the product.

### (3) Conformity of a circuit

We strongly recommend to make sure that Negative resistance (Gain) of IC is designed to be 3 times the ESR (Equivalent Series Resistance) of crystal unit.

## 11. Storage conditions

Please store product in below conditions, and use within 6 months.

Temperature +18 to +30°C, and Humidity of 20 to 70 % in the packaging condition.

## 12. Manufacturing location

Kyocera Crystal Device Corporation Yamagata Plant

Kyocera Crystal Device Corporation Shiga Yohkaichi Plant

Kyocera Crystal Device (Thailand) Co., Ltd

## 13. Quality Assurance

To be guaranteed by Kyocera Crystal Device Quality Assurance Division

## 14. Quality guarantee

In case when Kyocera Crystal Device Corporation rooted failure occurred within 1year after its delivery, substitute product will be arranged based on discussion. Quality guarantee of product after 1 year of its delivery is waived.

## 15. Others

In case of any questions or opinions regarding the Specification, please have it in written manner within 45 days after issued date.